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|-----------------------------------|--|-------------------------|---|-------------|
| Notice of References Cited | | Application/Control No. | Applicant(s)/Patent Under Reexamination | |
| | | 10/751,081 | SCHOTTLER, JOSEPH J. | |
| Examiner | | Art Unit | | Page 1 of 1 |
| Tuan T. Lam | | 2816 | | |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|---------------------|----------------|
| X | A | US-RE32,526 | 10-1987 | Hochstein, Peter A. | 327/432 |
| X | B | US-5,371,418 | 12-1994 | Leipold et al. | 327/109 |
| X | C | US-6,236,122 | 05-2001 | Maeda et al. | 307/125 |
| X | D | US-2002/0145893 | 10-2002 | Yamamoto, Tomohisa | 363/59 |
| X | E | US-6,531,895 | 03-2003 | Barrett et al. | 326/82 |
| X | F | US-2003/0197543 | 10-2003 | Imai, Hiroshi | 327/427 |
| X | G | US-6,625,516 | 09-2003 | Niimi et al. | 700/170 |
| X | H | US-2004/0130379 | 07-2004 | Bolz et al. | 327/374 |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
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| | T | | | | | |

NON-PATENT DOCUMENTS

| | | |
|---|---|---|
| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
| | U | |
| | V | |
| | W | |
| | X | |

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